PESO	ķ	•		•	PATENT Sheet 1	APPLICATION of 1	
8 2003 6	PM P	TO-1449		ATTY. DOCKET NO.	APPLICATION NO.	CONFIRMATION	
Š	FORM PTO-1449 SIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)			200312110-1	10/621,484	:	
TO BELLEVILLE				APPLICANT	APPLICANT		
MINE				Stan E. LEIGH, t al.			
				FILING DATE	GROUP		
				07/16/03	1		
REFERE	NCE [DESIGNATION	U.S. PAT	ENT DOCUMENTS			
EXAMINER INITIAL		DOCUMENT NUMBER	PUBLICATION DATE	NAME	Pages, Column Relevant Passages	s, Lines Where or Figures Appear	
	1A			·			
	1B						
	1C						
	1D					· · · · · · · · · · · · · · · · · · ·	
					•		
	1 E						
	1E 1F						
	1F						
	1F 1G						
	1F 1G 1H						

FOREIGN PATENT DOCUMENTS

DOCUM		Where Translation attached
IL		
IM		
IN		
10		
IP		

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, etc.)

ζ.V.	10	H. CERIC, et al.; "ELECTROMIGRATION INDUCED EVOLUTION OF VOIDS IN CURRENT CROWDING AREAS OF INTERCONNECTS"; 2002 IEEE; Proceedings of 9th IPFA 2002, Singapor Pages 140-144.					
	1R						
	15						
EXAMIN		A. Vale -	DATE CONSIDERED	11/16/04			